

<b>Notice of References Cited</b>	Application/Control No. 09/515,905	Applicant(s)/Patent Under Reexamination NAKAZONA ET AL.	
	Examiner Ba Huynh	Art Unit 2173	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,898,434	04-1999	Small et al.	345/810
	B	US-5,963,916	10-1999	Kaplan, Joshua D.	705/26
	C	US-5,734,719	03-1998	Tsevdos et al.	700/234
	D	US-6,118,450	09-2000	Proehl et al.	345/810
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

772